Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
09/773,407	YIN ET AL.
Examiner	Art Unit
Longhit Chai	2131

	SEARCHED			
Class	Subclass	Date	Examiner	
713	182-186 200-262	6/5/05	SPIL	
345	173	6/5/05	H3 C	
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INTERFERENCE SEARCHED			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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